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Boulder Laboratories

PRECISION CALIBRATION OF
RF VACUUM TUBE VOLTMETERS

BY

L. F. BEHRENT



U. S. DEPARTMENT OF COMMERCE
NATIONAL BUREAU OF STANDARDS

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ABSTRACT

Before any rf vacuum tube voltmeter is to be calibrated, it should be tested for several weeks to determine how well it may retain its calibration. In this way effort lost in trying to calibrate it to an accuracy beyond its inherent capabilities can be avoided. AT voltmeters, Thermal Converters and RF Micropotentiometers as working standards provide simple, accurate and yet rapid means for calibrating vacuum tube voltmeters.

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1.00 Introduction

In describing calibration procedures for rf vacuum tube voltmeters, the discussion will be limited to voltmeters having an unbalanced, two-terminal input with one side at ground potential. The rf voltages used in making the calibrations will be confined to cw, essentially sinusoidal, voltages.

Vacuum-tube voltmeters are not inherently stable. From a survey conducted at NBS some time ago in which the calibrations of several different types of vacuum-tube voltmeters were checked against the primary standards of rf voltage, changes in calibration in some cases as high as 10-20 percent were observed over a period of only a few months. Therefore, before any vacuum-tube voltmeter is calibrated, it should be checked against a reliable standard for a period of several weeks to determine its probable stability. The calibration procedure used should give an accuracy commensurate with the capabilities of the voltmeter under test.

2.00 Calibration

Calibration activities can appropriately be divided into levels or echelons according to the range of accuracies and the purposes they serve in the calibrations structure. A practical breakdown has been proposed 1 / in which three echelons are set up. In Echelon I are included the Primary and Secondary standards maintained by the NBS. Echelon II includes the working standards maintained by standards laboratories in industry, other branches of government and universities. These standards are traceable to the NBS and are used in calibrating the working standards of Echelon III. The third level, Echelon III, contains the standards used in calibrating the instruments used by the consumer - for example, production line test departments and those engaged in the repair and calibration of instruments. Vacuum-tube voltmeters generally should be calibrated at the third echelon because they lack the stability to warrant the extra effort and expense involved in higher order accuracy calibrations.

2.10 Accuracy

The accuracies which may be expected depend upon both rf voltage level and frequency. Below 10 Mc, accuracies of 0.5 - 2 percent can be obtained, while 10 - 25 percent can be expected between 100 and 1000 Mc. So it is evident that at lower frequencies, even in Echelon III, accuracies better than needed for VTVM calibrations are possible.

2.20 Working Standards

Suitable working standards which may be used to calibrate VTVM's are AT voltmeters, Micropotentiometers, and thermal converters 2, 3, 4 / -- the Micropotentiometer for calibrating millivolt rf voltage levels at all frequencies, thermal converters for higher voltages up to 30 or 100 Mc, and AT voltmeters to complete the coverage to 1000 Mc.

2.30 Procedure

In general, to calibrate a VTVM, the working standard and the voltmeter to be tested are connected in parallel, and with rf voltage applied to both, the level is adjusted to give the desired indication of the test instrument. The actual magnitude of the rf voltage applied is then determined from the calibrated indication of the working standard. The detailed steps will depend on the working standard being used.

For rf voltage levels of 1-100 mv the RF Micropotentiometer is the best working standard to use at the present time. Table I shows a typical selection of such standards to give complete voltage coverage within this range. The basic circuit illustrating the use of RF Micropotentiometers in VTVM calibration is shown in Figure 1 a.

Table I

Typical Selection of RF Micropotentiometers for MV Levels

<u>Thermoelement rating, ma</u>	<u>Resistance Element, ohms</u>	<u>Standardized mv output</u>
100	1.0	20 - 100
25	1.0	5 - 25
5	1.0	1 - 5

The rf portion of the calibration procedure is as follows:

- 1) With the rf input terminals of the VTVM connected to the working standard's output terminals, energize the voltmeter according to the manufacturer's recommended procedure. Allow a fifteen minute warm-up period before beginning the tests, unless the manufacturer or user specifies a longer one.
- 2) Make meter zero corrections and/or any other adjustments specified by the user or manufacturer. (Many VTVM's capable of measuring millivolts have a suppressed zero, in which case the zero adjustment will be omitted.)
- 3) Apply a sinusoidal, cw, rf voltage to give the desired test voltmeter indication, and record the working standard's millivoltmeter indication.
- 4) Remove the rf signal, and, if the voltmeter does not have a suppressed zero, recheck the zero. If the zero requires resetting the validity of the rf calibration is doubtful. The data for that measurement should be discarded and the test repeated.

For each point on the meter of the VTVM to be calibrated at least five independent rf measurements with the working standard should be made.

There are two ways in which the correction for rf error in the RF Micropotentiometer may have been expressed in the higher echelon calibration data. It might have been expressed as a percentage by which, for a given current in the resistance element, the rf voltage output was greater or less than the d-c calibration value at each frequency. Or, for a given current level in the resistance, the actual output at dc and each radio frequency may have been given. In either case it is necessary to use dc to calibrate the thermoelement monitoring the current into the resistance element as shown in Figure 1 b. This d-c calibration may be made after each measurement, for best accuracy, or one complete calibration can be obtained and plotted in graph form so that d-c data for individual rf measurement points can be read from the graph. For such a graph, some 20 - 30 points of d-c thermocouple millivolt output versus d-c microvolt output across the resistance element as measured with a precision d-c measuring potentiometer must be plotted.

Where a d-c calibration is made immediately following an rf measurement, enough d-c current is applied to the RF Micropotentiometer to reproduce the millivoltmeter indication obtained during the rf measurement, and the d-c output in millivolts is measured. The circuit of Figure 1b applies to both procedures. Having completed the d-c calibration and having the rf to d-c correction, the actual rf voltage output can be accurately calculated.

For rf voltage levels above 0.1 volt at frequencies of 100 Mc and less, thermal converters are suitable working standards. Figure 2 presents the rather simple circuit arrangement. The test voltmeter and the working standard are connected in parallel and to an rf source through appropriate filters.

The calibration procedure contains very few steps. After the preliminary steps of allowing an adequate "warm-up" period to stabilize the VTVM, and the checking and adjustment of voltmeter zeros, only two steps remain. Apply sufficient rf voltage to produce the desired meter indication on the VTVM and record the indication of the working standard.

Upon completion of the test, remove the rf voltage and recheck zero settings. As before, any zero error renders the rf test invalid and the measurement must be repeated.

Above 100 Mc, a satisfactory working standard is the AT voltmeter. The circuit arrangement of Figure 2 applies here, too, except that where capacitive AT voltmeters are used a frequency meter must be added to permit checking and adjusting the rf source to the same frequencies at which the working standard was calibrated. Except for several precautions which will be discussed in the following text, the procedure outlined for thermal converters applies here also.

2.40 Precautions

While VTVM's are not stable, as was pointed out before, following the precautions outlined below will help to realize the best performance of which they are capable.

- 1) Regulate the line voltage energizing the test instrument. The use of a good a-c regulator can help reduce voltmeter zero fluctuations may reduce calibration instability. The line voltage applied during

tests should be recorded and reported so that subsequent users can adjust the line voltage to the same value at the sites where the meters are used for measurements. Failure to do this can introduce additional error.

- 2) Filter the rf voltage applied to the VTVM during calibration. Many vacuum-tube voltmeters are peak reading instruments. The presence of harmonics in the applied rf voltage can add several percent error to the measurements in such cases. The rf source should be filtered sufficiently to place the harmonics 50 - 60 db below the fundamental.
- 3) Use only those rf sources whose rf output voltages have good amplitude stability during the short time it takes to make a measurement. For example: if an rf calibration measurement accuracy of ± 5 percent is required, the output amplitude of the rf source should remain stable to within ± 0.5 percent during the measurement.
- 4) Check the zero setting of the test meter both before and after each measurement. This point was discussed before but it cannot be overemphasized.
- 5) Check the entire rf circuit, including rf source, connecting cables, the working standard and the test VTVM for rf leakage currents. It sometimes becomes necessary to place the rf source inside a double-screened box and to apply external shielding to connecting rf cables ⁵/ . Quite frequently vacuum-tube voltmeters with high-frequency probes are not sufficiently shielded and it becomes necessary to place external shielding over the housing of the probe and the cable connecting the probe output to the voltmeter proper. See Figure 3.
- 6) Connect the test voltmeter's rf input terminals to the working standard with the shortest connections possible. Above a few megacycles banana pins and clip leads are not usable because of the error these lead lengths introduce. Even coaxial connections can introduce errors at very high frequencies because of the voltage standing wave in this length of transmission line between the applied rf voltage and the terminals of the test meter. To illustrate refer to Figure 4. Here an RF Micropotentiometer is the working

standard. Its standardized rf output voltage is coupled to the input terminals of the VTVM through an adapter. This arrangement is satisfactory to about 5 Mc. Above this frequency, error will be caused by the lead lengths and discontinuities introduced by Adapter A. The accurately known rf voltage exists at the voltage reference plane b-b (at the front face of the type N output of the RF Micropotentiometer).

Another illustration is shown in Figure 5 where a vacuum-tube voltmeter probe is connected in parallel with an AT voltmeter for high-frequency calibration. To illustrate the importance of short connections, standard type N connectors and adapters are used. The plane in which the rf voltage is known at the working standard is d-d. With a type N connection on the test voltmeter probe, known rf voltage should be applied to the probe at the voltage reference plane f-f. At high radio frequencies, again because of the approximately 4.5 cm length of transmission line and the discontinuities in the connectors, the voltage at plane f-f will differ from the voltage at d-d. At 100 Mc a difference of several percent may occur. This is aggravated, too, because both the VTVM and the AT voltmeter are high impedances and the transmission line between them is not terminated in its characteristic impedance anywhere - consequently a very high standing wave ratio exists in the line section between them. Special T connections should be constructed to reduce the distance between the standard and the test meter as much as possible and still allow the rf voltage to be fed to them in parallel. In order that such special T connectors may be usable over the widest possible frequency range, the length of the T between the voltmeter under test and the standard should be about one eighth of an inch.

3.00 Conclusions

The importance of knowing the capabilities of a VTVM before attempting calibration cannot be emphasized too strongly. There have been many instances where users, without prior investigation of voltmeter stability, have insisted upon 1 or 2 percent calibrations of VTVM's. In a matter of days, the calibration of the test voltmeter had already changed by a percentage greater than the specified accuracy and the calibration had to be terminated.

Because one cannot predict when VTVM may lose its calibration, it is recommended that any facility using VTVM's as voltage standards calibrate at least three to permit intercomparison. When one of them

disagrees with the other two it should then be removed and recalibrated, after making suitable stability tests to determine whether or not it is still sufficiently stable to warrant recalibration.

Whatever means of connection is used for connecting the test meter to the working standard, the same rf connection should be employed in making measurements or additional error due to connections will be introduced.

The working standards recommended here are capable of much greater accuracy than is required for these tests and may be used in both Echelon I and Echelon II.

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5. FIGURES

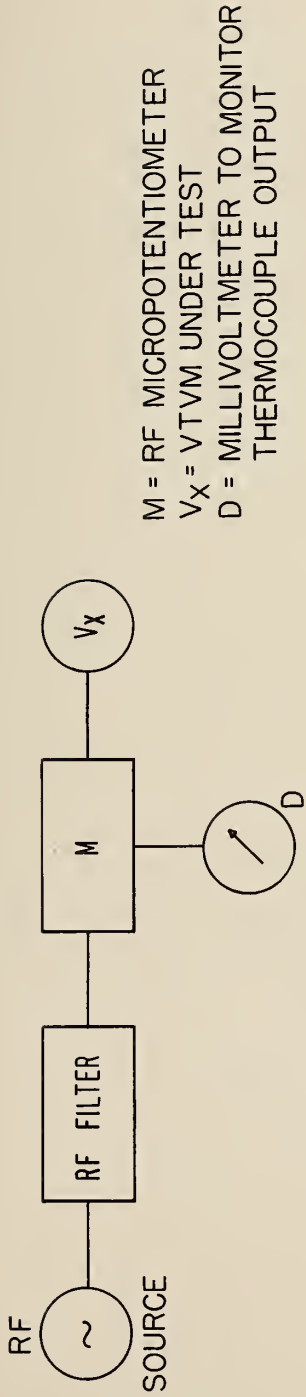


Figure 1a

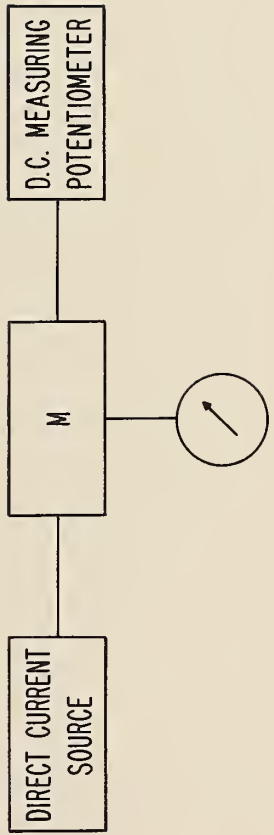


Figure 1b

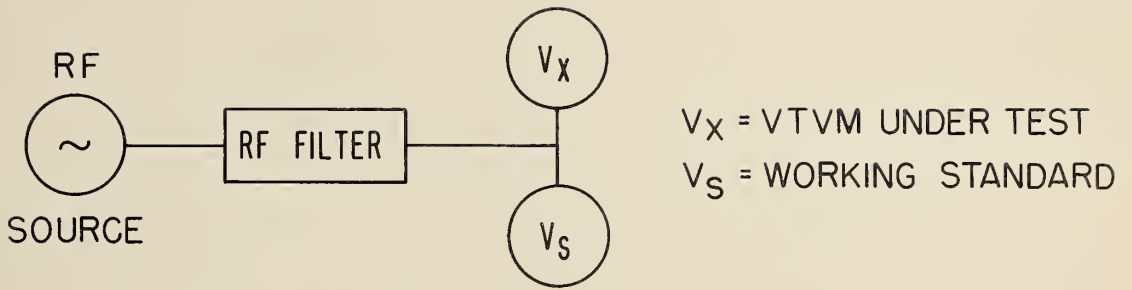


Figure 2

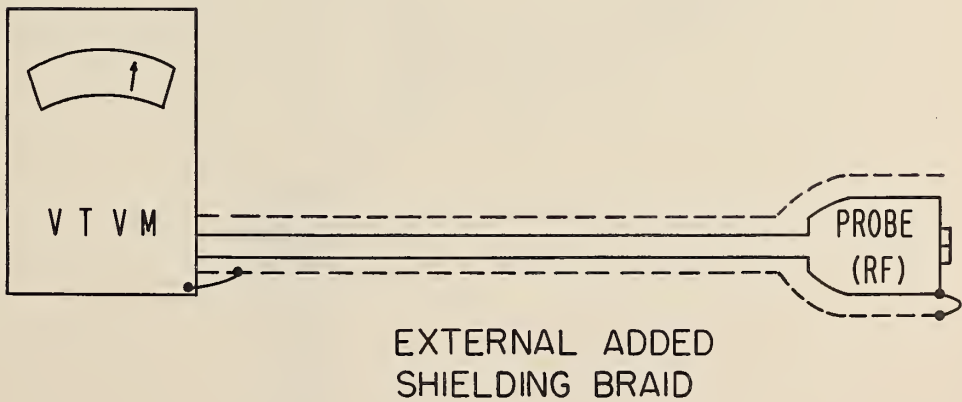


Figure 3

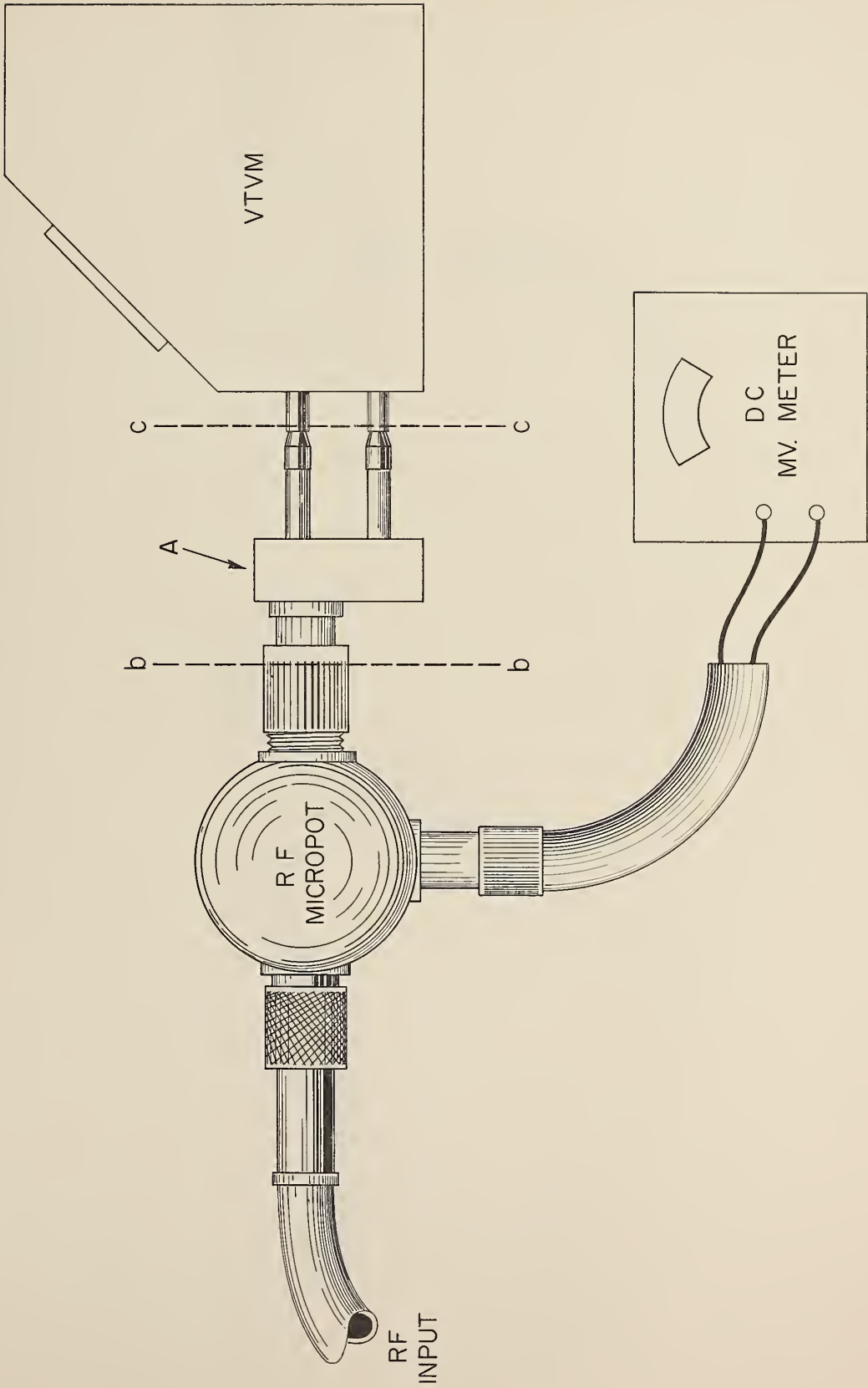


Figure 4

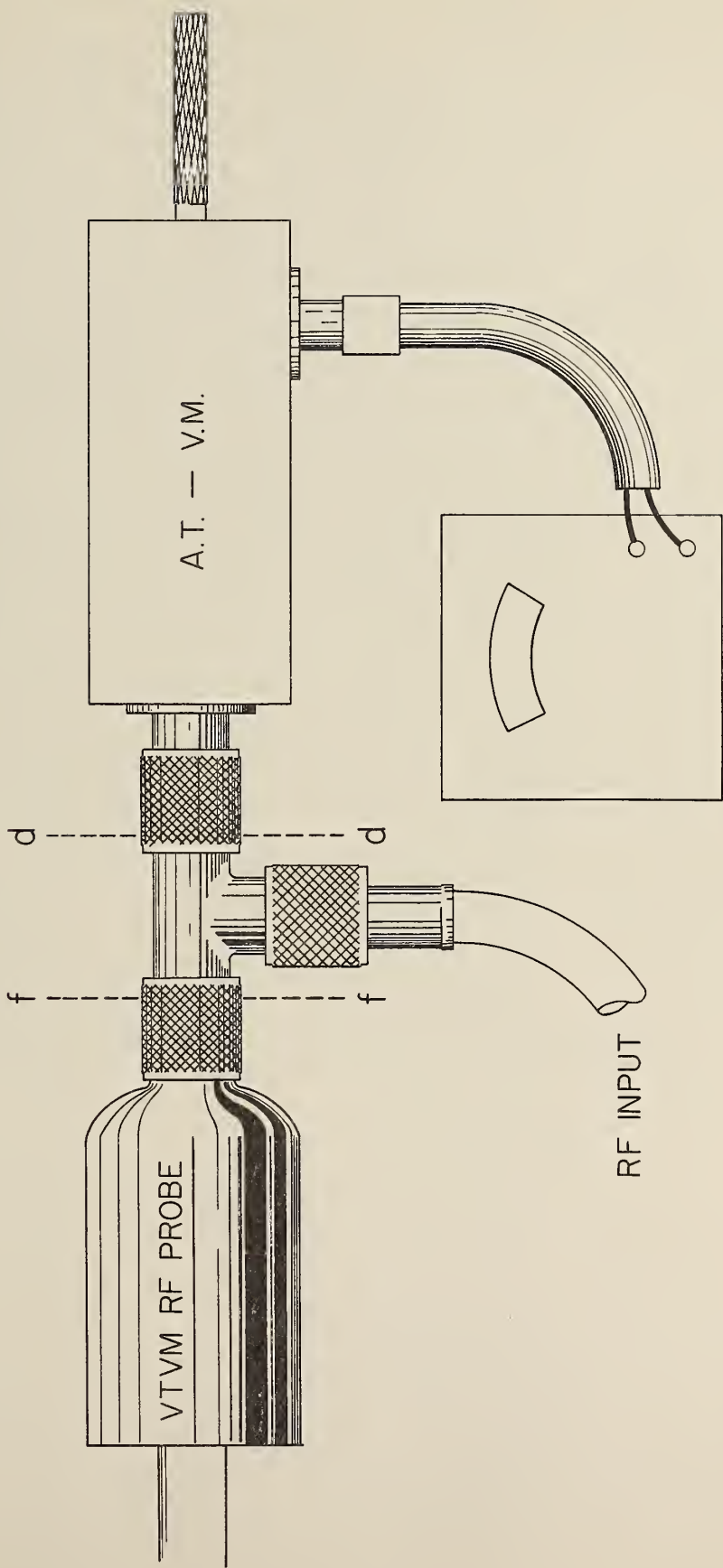


Figure 5

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THE NATIONAL BUREAU OF STANDARDS

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